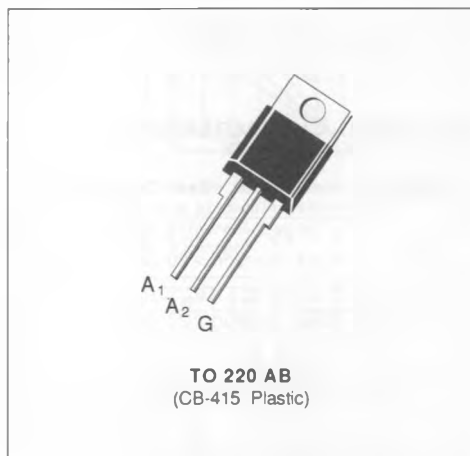


SNUBBERLESS TRIACS

- $I_{TRMS} = 12\text{ A}$ at $T_c = 95\text{ }^\circ\text{C}$.
- $V_{DRM} : 200\text{ V}$ to 800 V .
- $I_G = 35\text{ mA}$ (QI-II-III).
- GLASS PASSIVATED CHIP.
- HIGH SURGE CURRENT : $I_{TSM} = 120\text{ A}$.
- HIGH COMMUTATION CAPABILITY :
 $(di/dt)_c > 6.5\text{ A/ms}$ without snubber.


DESCRIPTION

New range suited for applications such as phase control and static switching on inductive or resistive load.

ABSOLUTE RATINGS (limiting values)

Symbol	Parameter		Value	Unit
I_{TRMS}	RMS on-state current (360 ° conduction angle)	$T_c = 95\text{ }^\circ\text{C}$	12	A
I_{TSM}	Non repetitive surge peak on-state current (T_j initial = $25\text{ }^\circ\text{C}$)	$t = 8.3\text{ ms}$	126	A
		$t = 10\text{ ms}$	120	
I^2t	I^2t value	$t = 10\text{ ms}$	72	A^2s
di/dt	Critical rate of rise of on-state current (1)	Repetitive $F = 50\text{ Hz}$	20	A / μs
		Non Repetitive	100	
T_{stg} T_j	Storage and operating junction temperature range		- 40, + 150 - 40, + 125	$^\circ\text{C}$ $^\circ\text{C}$

Symbol	Parameter	BTB 12-					Unit
		200 CW	400 CW	600 CW	700 CW	800 CW	
V_{DRM}	Repetitive peak off-state voltage (2)	± 200	± 400	± 600	± 700	± 800	V

(1) Gate supply : $I_G = 350\text{ mA}$ - $di_G / dt = 1\text{ A} / \mu\text{s}$.

(2) $T_j = 125\text{ }^\circ\text{C}$.

THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
$R_{th(j-a)}$	Junction to ambient	60	°C/W
$R_{th(j-c)DC}$	Junction to case for DC	2.7	°C/W
$R_{th(j-c)AC}$	Junction to case for 360° conduction angle (F = 50 Hz)	2	°C/W

GATE CHARACTERISTICS (maximum values)

$P_{GM} = 40\text{ W}$ ($t = 10\ \mu\text{s}$) $P_{G(AV)} = 1\text{ W}$ $I_{GM} = 4\text{ A}$ ($t = 10\ \mu\text{s}$) $V_{GM} = 16\text{ V}$ ($t = 10\ \mu\text{s}$).

ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions			Quadrants	Min.	Typ.	Max.	Unit
I_{GT}	$T_j = 25\text{ °C}$	$V_D = 12\text{ V}$	$R_L = 33\ \Omega$	I-II-III	1		35	mA
	Pulse duration > 20 μs							
V_{GT}	$T_j = 25\text{ °C}$	$V_D = 12\text{ V}$	$R_L = 33\ \Omega$	I-II-III			1.5	V
	Pulse duration > 20 μs							
V_{GD}	$T_j = 125\text{ °C}$	$V_D = V_{DRM}$	$R_L = 3.3\text{ k}\Omega$	I-II-III	0.2			V
	Pulse duration > 20 μs							
I_{H^*}	$T_j = 25\text{ °C}$	$I_T = 100\text{ mA}$	$R_L = 140\ \Omega$				35	mA
	Gate open							
I_L	$T_j = 25\text{ °C}$	$V_D = 12\text{ V}$	$I_G = 350\text{ mA}$	I-III			50	mA
				II			80	
	Pulse duration > 20 μs							
V_{TM}^*	$T_j = 25\text{ °C}$	$I_{TM} = 17\text{ A}$	$t_p = 10\text{ ms}$				1.6	V
I_{DRM}^*	$T_j = 25\text{ °C}$	V_{DRM} rated	Gate open				0.01	mA
	$T_j = 125\text{ °C}$						2	
dv/dt^*	$T_j = 125\text{ °C}$	Gate open Linear slope up to 0.67 V_{DRM}			250	500		V/ μs
$(di/dt)_c^*$	$T_j = 125\text{ °C}$	V_{DRM} rated Without snubber			6.5	13		A/ms
t_{gt}	$T_j = 25\text{ °C}$	$di_G/dt = 1\text{ A}/\mu\text{s}$	$I_G = 350\text{ mA}$	I-II-III		2		μs
	$I_T = 17\text{ A}$	$V_D = V_{DRM}$						

* For either polarity of electrode A₂ voltage with reference to electrode A₁.

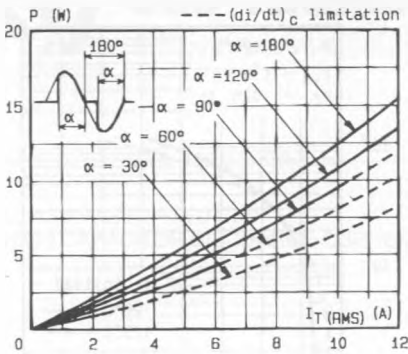


Fig. 1 - Maximum mean power dissipation versus RMS on-state current ($F = 60 \text{ Hz}$).

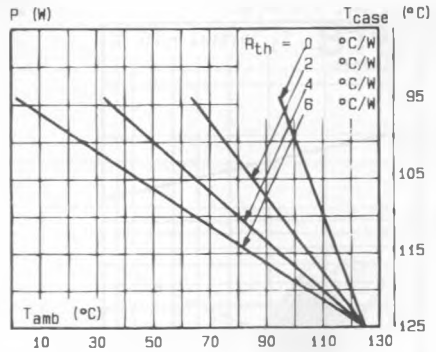


Fig. 2 - Correlation between maximum mean power dissipation and maximum allowable temperatures (T_{amb} and T_{case}) for different thermal resistances heatsink + contact.

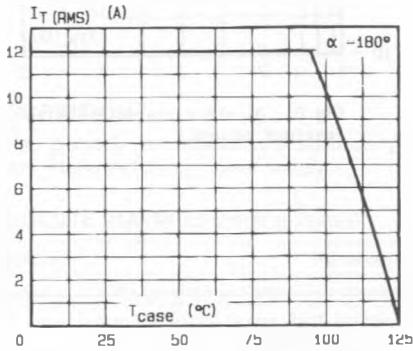


Fig. 3 - RMS on-state current versus case temperature.

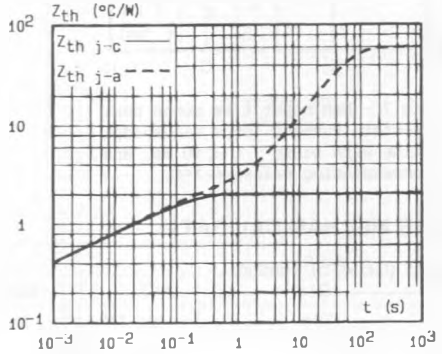


Fig. 4 - Thermal transient impedance junction to case and junction to ambient versus pulse duration.



Fig. 5 - Relative variation of gate trigger current and holding current versus junction temperature.

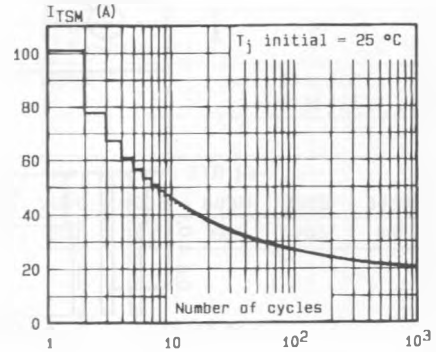


Fig. 6 - Non repetitive surge peak on-state current versus number of cycles.

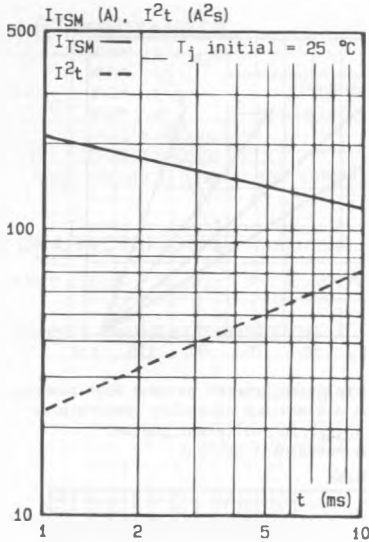


Fig.7 - Non repetitive surge peak on-state current for a sinusoidal pulse with width : $t \leq 10$ ms, and corresponding value of I^2t .

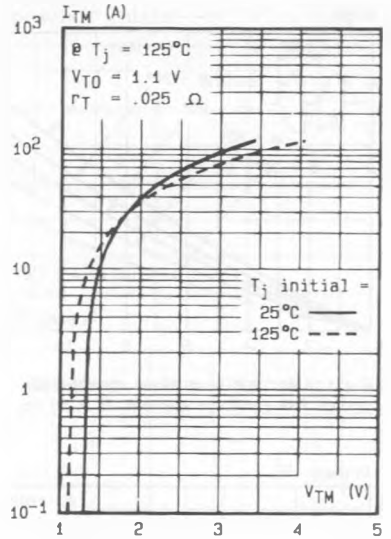
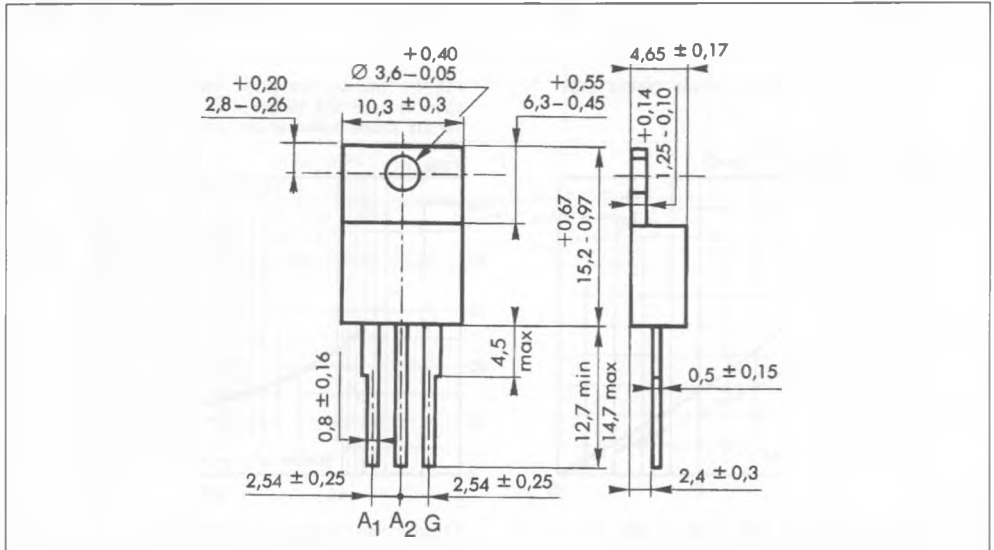


Fig.8 - On-state characteristics (maximum values).

PACKAGE MECHANICAL DATA

TO 220 AB (CB-415) Plastic



Cooling method : by conduction (method C)
 Marking : type number
 Weight : 2,2 g